8-Bit Bidirectional Voltage-Level Translator for Open-Drain and Push-Pull Applications

FEATURES

- **No Direction-Control**
- **Data Rates**
  24Mbps (Push-Pull)
  2Mbps (Open-Drain)
- **1.65V to 5.5V on A ports and 2.3V to 5.5V on B Ports ($V_{CCA} \leq V_{CCB}$)**
- **V_{CC} Isolation: If Either V_{CC} is at GND, Both Ports are in the High-Impedance State**
- **No Power-Supply Sequencing Required: Either V_{CCA} or V_{CCB} can be Ramped First**
- **I_{OFF}: Supports Partial-Power-Down Mode Operation**
- **Extended Temperature: -40°C to +85°C**

APPLICATIONS

- **Handset**
- **Smartphone**
- **Tablet**
- **Desktop PC**

DESCRIPTION

This 8-bit non-inverting translator is a bidirectional voltage-level translator and can be used to establish digital switching compatibility between mixed-voltage systems. It uses two separate configurable power-supply rails, with the A ports supporting operating voltages from 1.65V to 5.5V while it tracks the V_{CCA} supply, and the B ports supporting operating voltages from 2.3V to 5.5V while it tracks the V_{CCB} supply. This allows the support of both lower and higher logic signal levels while providing bidirectional translation capabilities between any of the 1.8V, 2.5V, 3.3V and 5V voltage nodes.

When the output-enable (OE) input is low, all I/Os are placed in the high-impedance state, which significantly reduces the power-supply quiescent current consumption. OE has an internal pull-down current source, if V_{CCA} is powered.

To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pull-down resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

The RS0108 is available in Green QFN3*3-20L and TSSOP20 packages. It operates over an ambient temperature range of -40°C to +85°C.

Device Information (1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
RS0108	TSSOP20(20)	6.50mm×4.40mm
	QFN3*3-20L(20)	3.00mm×3.00mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Functional Block Diagram

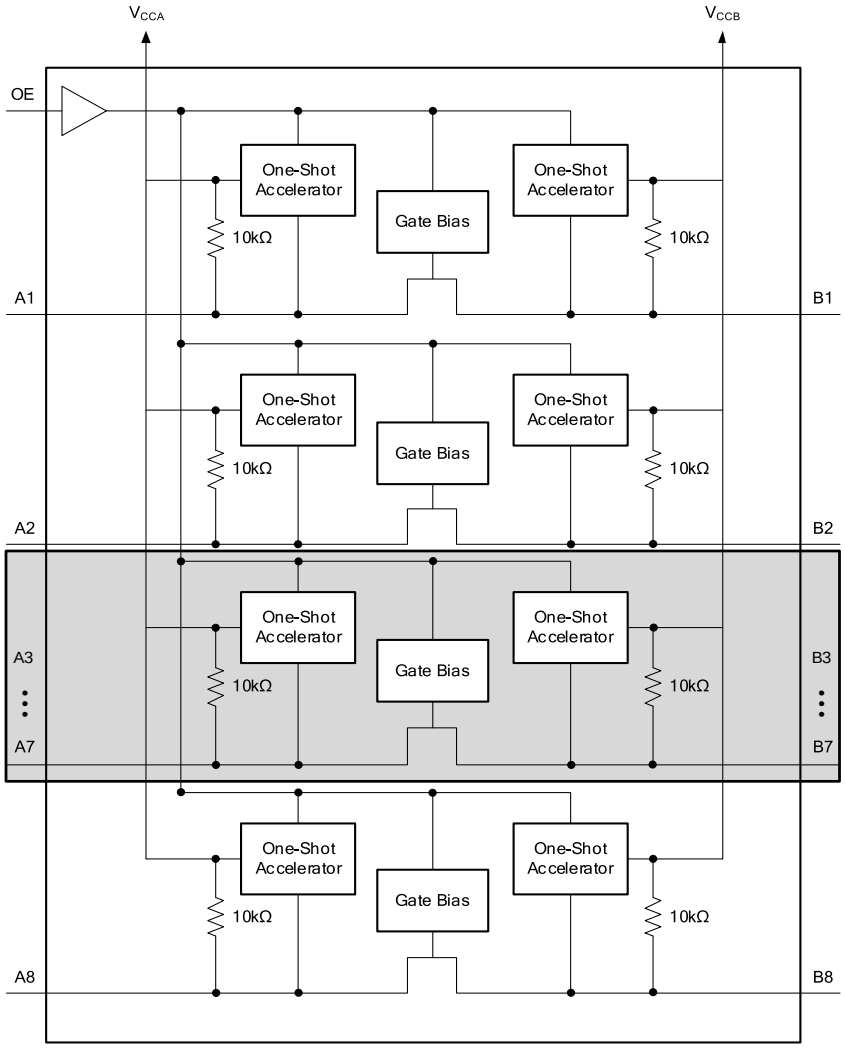


Figure 1.Function Block Diagram

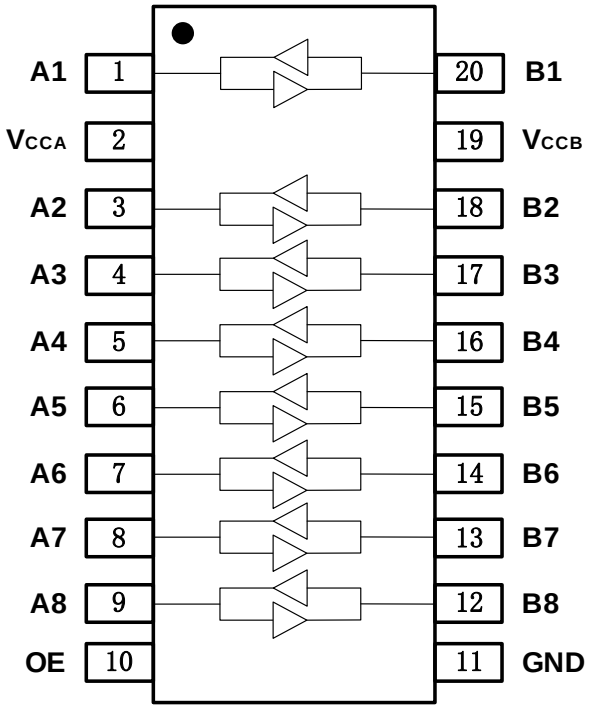
Revision History

Note: Page numbers for previous revisions may different from page numbers in the current version.

VERSION	Change Date	Change Item
A.1	2020/12/2	Initial version completed
A.2	2021/01/09	Add Moisture Sensitivity Level information

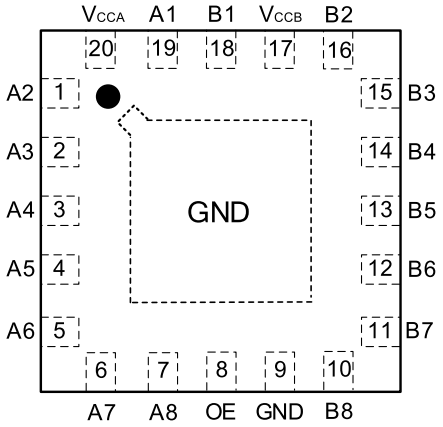
PIN CONFIGURATIONS

(TOP VIEW)



TSSOP20

(TOP VIEW)



QFN3*3-20L

PIN DESCRIPTION

PIN		NAME	TYPE (1)	FUNCTION
TSSOP20	QFN3*3-20L			
1	19	A1	I/O	Input/output A1. Reference to V_{CCA}.
2	20	V_{CCA}	P	A Port Supply Voltage.1.65V ≤ V_{CCA} ≤ 5.5V and V_{CCA} ≤ V_{CCB}.
3	1	A2	I/O	Input/output A2. Reference to V_{CCA}.
4	2	A3	I/O	Input/output A3. Reference to V_{CCA}.
5	3	A4	I/O	Input/output A4. Reference to V_{CCA}.
6	4	A5	I/O	Input/output A5. Reference to V_{CCA}.
7	5	A6	I/O	Input/output A6. Reference to V_{CCA}.
8	6	A7	I/O	Input/output A7. Reference to V_{CCA}.
9	7	A8	I/O	Input/output A8. Reference to V_{CCA}.
10	8	OE	I	Output Enable (Active High). Pull OE low to place all outputs in 3-state mode. Referenced to V_{CCA}.
11	9	GND	–	Ground.
12	10	B8	I/O	Input/output B8. Reference to V_{CCB}.
13	11	B7	I/O	Input/output B7. Reference to V_{CCB}.
14	12	B6	I/O	Input/output B6. Reference to V_{CCB}.
15	13	B5	I/O	Input/output B5. Reference to V_{CCB}.

16	14	B4	I/O	Input/output B4. Reference to V_{CCB}.
17	15	B3	I/O	Input/output B3. Reference to V_{CCB}.
18	16	B2	I/O	Input/output B2. Reference to V_{CCB}.
19	17	V_{CCB}	P	B Ports Supply Voltage.2.3V ≤ V_{CCB} ≤ 5.5V.
20	18	B1	I/O	Input/output B1. Reference to V_{CCB}.
-	Exposed Pad	GND	-	Exposed pad should be soldered to PCB board and connected to GND or left floating.

(1) I=input, O=output, I/O=input and output, P=power

SPECIFICATIONS

Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted) (1)

SYMBOL	PARAMETER		MIN	MAX	UNIT
V_{CCA}	Supply Voltage Range		-0.3	6.0	V
V_{CCB}	Supply Voltage Range		-0.3	6.0	V
V_I(2)	Input Voltage Range	A port	-0.3	6.0	
		B port	-0.3	6.0	V
		OE	-0.3	6.0	
V_O(2)	Voltage range applied to any output in the high-impedance or power-off state	A port	-0.3	6.0	V
		B port	-0.3	6.0	
V_O(2)(3)	Voltage range applied to any output in the high or low state	A port	-0.3	V_{CCA}+0.3	V
		B port	-0.3	V_{CCB}+0.3	
I_{IK}	Input clamp current	V_I<0		-50	mA
I_{OK}	Output clamp current	Vo<0		-25	mA
I_O	Continuous output current			±50	mA
	Continuous current through V_{CCA}, V_{CCB} or GND			±100	mA
T_J	Junction Temperature			150	°C
T_{stg}	Storage temperature		-65	+150	

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
(3) The value of V_{CCA} and V_{CCB} are provided in the recommended operating conditions table.

ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM)	±5000	V
		Machine Model (MM)	±400	V

Recommended Operating Conditions

V_{CCI} is the supply voltage associated with the input port. V_{CCO} is the supply voltage associated with the output port.

PARAMETER	CONDITIONS		MIN	TYP	MAX	UNIT
Supply voltage (1)	V_{CCA}		1.65		5.5	V
	V_{CCB}		2.3		5.5	
High-level input voltage (V_{IH})	A-port I/Os	V_{CCA} = 1.65 V to 1.95 V V_{CCB} = 2.3 V to 5.5 V	V_{CCI} – 0.2		V_{CCI}	V
		V_{CCA} = 1.65 V to 3.6 V V_{CCB} = 2.3 V to 5.5 V	V_{CCI} – 0.4		V_{CCI}	V
	B-port I/Os	V_{CCA} = 1.65 V to 3.6 V V_{CCB} = 2.3 V to 5.5 V	V_{CCI} – 0.4		V_{CCI}	V
	OE input	V_{CCA} = 1.65 V to 3.6 V V_{CCB} = 2.3 V to 5.5 V	V_{CCA} × 0.8		5.5	V
Low-level input voltage (V_{IL})	A-port I/Os	V_{CCA} = 1.65 V to 3.6 V V_{CCB} = 2.3 V to 5.5 V	0		0.15	V
	B-port I/Os	V_{CCA} = 1.65 V to 3.6 V V_{CCB} = 2.3 V to 5.5 V	0		0.15	V
	OE input	V_{CCA} = 1.65 V to 3.6 V V_{CCB} = 2.3 V to 5.5 V	0		V_{CCA} × 0.25	V
Input transition rise or fall rate(Δt/Δv)		A-port I/Os push-pull driving			10	ns/V
		B-port I/Os push-pull driving			10	ns/V
		Control input			10	ns/V
T_A Operating free-air temperature			-40		85	°C

(1) V_{CCA} must be less than or equal to V_{CCB}.
(2) The maximum V_{IL} value is provided to ensure that a valid V_{OL} is maintained. The V_{OL} value is V_{IL} plus the voltage drop across the pass gate transistor.

PACKAGE/ORDERING INFORMATION

PRODUCT	ORDERING NUMBER	TEMPERATURE RANGE	PACKAGE LEAD	PACKAGE MARKING (1)	MSL(2)	PACKAGE OPTION
RS0108	RS0108YTQC20	-40°C ~+85°C	QFN3*3-20L	RS0108	MSL3	Tape and Reel,5000
	RS0108YQ20	-40°C ~+85°C	TSSOP20	RS0108	MSL3	Tape and Reel,4000

NOTE:

(1) There may be additional marking, which relates to the lot trace code information(data code and vendor code)，the logo or the environmental category on the device.

(2) MSL, The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications.

Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (1) (2) (3)

PARAMETER		CONDITIONS	V_{CCA}	V_{CCB}	TEMP	MIN	TYP	MAX	UNITS
V_{OHA}	Port A output high voltage	I_{OH} = –20 μA $V_{IB} \geq V_{CCB}$ – 0.4V	1.65V to 5.5V	2.3V to 5.5V	Full	V_{CCA} × 0.7		5.5	V
V_{OLA}	Port A output low voltage	I_{OL} = 1mA $V_{IB} \leq$ 0.15 V	1.65V to 5.5V	2.3V to 5.5V	Full			0.3	
V_{OHB}	Port B output high voltage	I_{OH} = –20 μA $V_{IA} \geq V_{CCA}$ – 0.4 V	1.65V to 5.5V	2.3V to 5.5V	Full	V_{CCB} × 0.7			
V_{OLB}	Port B output low voltage	I_{OL} = 1mA $V_{IA} \leq$ 0.15 V	1.65V to 5.5V	2.3V to 5.5V	Full			0.3	
I_I	Input leakage current	OE	1.65V to 5.5V	2.3V to 5.5V	+25°C			±1	μA
					Full			±1.5	
I_{off}	Partial power down current	A Ports	0V	0V to 5.5V	+25°C			±0.5	μA
					Full			±1	
		B Ports	0V to 5.5V	0V	+25°C			±0.5	μA
					Full			±1	
I_{OZ}	High-impedance State output current	A or B port OE=0V	1.65V to 5.5V	2.3V to 5.5V	+25°C			±0.5	μA
					Full			±1	
I_{CCA}	V_{CCA} supply current	$V_I = V_O$ = open I_O = 0	1.65V to V_{CCB}	2.3V to 5.5V	Full			2.0	μA
			5.5V	0V	Full			2.0	
			0V	5.5V	Full			-1	
I_{CCB}	V_{CCB} supply current	$V_I = V_O$ = open I_O = 0	1.65V to V_{CCB}	2.3V to 5.5V	Full			20	μA
			5.5V	0V	Full			-1	
			0V	5.5V	Full			1	
I_{CCA} + I_{CCB}	Combined supply current	$V_I = V_{CCI}$ or GND I_O = 0	1.65V to V_{CCB}	2.3V to 5.5V	Full			30	μA
I_{CCZA}	V_{CCA} supply current	$V_I = V_{CCI}$ or 0V I_O = 0, OE=0V	1.65V to V_{CCB}	2.3V to 5.5V	Full			1	μA
I_{CCZB}	V_{CCB} supply current	$V_I = V_{CCI}$ or 0V I_O = 0, OE=0V	2.3V to 5.5V	2.3V to 5.5V	Full			1	μA
C_I	Input capacitance	OE	3.3V	3.3V	+25°C		2.5		pF
C_{IO}	Input-to-output internal capacitance	A port	3.3V	3.3V	+25°C		5		pF
		B port	3.3V	3.3V	+25°C		5		

(1) V_{CCI} is the V_{CC} associated with the input port.
(2) V_{CCO} is the V_{CC} associated with the output port
(3) V_{CCA} must be less than or equal to V_{CCB}.

Timing Requirements

V_{CCA}=1.8V±0.15 V

		V_{CCB}=2.5V ±0.2V	V_{CCB}=3.3V ±0.2V	V_{CCB}=5V ±0.2V	UNIT
		TYP	TYP	TYP	
Data rate	Push-pull driving	21	22	24	Mbps
	Open-drain driving	2	2	2	
Pulse duration(t_w)	Push-pull driving (data inputs)	47	45	41	ns
	Open-drain driving (data inputs)	500	500	500	

V_{CCA}=2.5V±0.15 V

		V_{CCB}=2.5V ±0.2V	V_{CCB}=3.3V ±0.2V	V_{CCB}=5V ±0.2V	UNIT
		TYP	TYP	TYP	
Data rate	Push-pull driving	20	22	24	Mbps
	Open-drain driving	2	2	2	
Pulse duration(t_w)	Push-pull driving (data inputs)	50	45	41	ns
	Open-drain driving (data inputs)	500	500	500	

V_{CCA}=3.3V±0.15 V

		V_{CCB}=3.3V ±0.2V	V_{CCB}=5V ±0.2V	UNIT
		TYP	TYP	
Data rate	Push-pull driving	23	24	Mbps
	Open-drain driving	2	2	
Pulse duration(t_w)	Push-pull driving (data inputs)	43	41	ns
	Open-drain driving (data inputs)	500	500	

V_{CCA}=5V±0.15 V

		V_{CCB}=5V ±0.2V	UNIT
		TYP	
Data rate	Push-pull driving	24	Mbps
	Open-drain driving	2	
Pulse duration(t_w)	Push-pull driving (data inputs)	41	ns
	Open-drain driving (data inputs)	500	

Switching Characteristics: V_{CCA}=1.8V ± 0.15V

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		CONDITIONS		V_{CCB}=2.5V±0.2V	V_{CCB}=3.3V±0.2V	V_{CCB}=5V±0.2V	UNITS
				TYP	TYP	TYP	
t_{PHL}	Propagation delay time high-to-low output	A-to-B	Push-pull driving	2.5	3.1	4.5	ns
			Open-drain driving	26.1	26.4	26.6	
t_{PLH}	Propagation delay time low-to-high output	A-to-B	Push-pull driving	4.2	3.7	3.6	ns
			Open-drain driving	221	183	143	
t_{PHL}	Propagation delay time high-to-low output	B-to-A	Push-pull driving	2.1	2.0	2.2	ns
			Open-drain driving	26.1	26.1	26.2	
t_{PLH}	Propagation delay time low-to-high output	B-to-A	Push-pull driving	1.8	1.6	1.5	ns
			Open-drain driving	173	89	66	
t_{en}	Enable time	OE-to-A or B		25	21	19	ns
t_{dis}	Disable time	OE-to-A or B		1250	1250	1250	ns
t_{rA}	Input rise time	A port rise time	Push-pull driving	6.9	6.1	5.6	ns
			Open-drain driving	118	39	13	
t_{rB}	Input rise time	B port rise time	Push-pull driving	5.8	4.8	4.1	ns
			Open-drain driving	166	127	75	
t_{fA}	Input fall time	A port fall time	Push-pull driving	3.0	2.8	2.7	ns
			Open-drain driving	1.9	1.7	1.6	
t_{fB}	Input fall time	B port fall time	Push-pull driving	4.8	6.2	8.4	ns
			Open-drain driving	2.3	2.4	2.8	
$t_{sk(O)}$	Skew(time), output	Channel-to-Channel Skew		0.5	0.5	0.5	ns
Maximum data rata		Push-pull driving		21	22	24	Mbps
		Open-drain driving		2	2	2	

Switching Characteristics: V_{CCA}=2.5V ± 0.15V

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		CONDITIONS		V_{CCB}=2.5V±0.2V	V_{CCB}=3.3V±0.2V	V_{CCB}=5V±0.2V	UNITS
				TYP	TYP	TYP	
t_{PHL}	Propagation delay time high-to-low output	A-to-B	Push-pull driving	2.8	3.4	5.0	ns
			Open-drain driving	26.3	26.5	26.6	
t_{PLH}	Propagation delay time low-to-high output	A-to-B	Push-pull driving	2.7	2.5	2.4	ns
			Open-drain driving	198	169	131	
t_{PHL}	Propagation delay time high-to-low output	B-to-A	Push-pull driving	2.5	2.4	2.5	ns
			Open-drain driving	26.4	26.5	26.6	
t_{PLH}	Propagation delay time low-to-high output	B-to-A	Push-pull driving	2.1	2.0	1.9	ns
			Open-drain driving	196	138	63	
t_{en}	Enable time	OE-to-A or B		24	20	17	ns
t_{dis}	Disable time	OE-to-A or B		1250	1250	1250	ns
t_{rA}	Input rise time	A port rise time	Push-pull driving	3.4	2.9	2.7	ns
			Open-drain driving	156	92	13	
t_{rB}	Input rise time	B port rise time	Push-pull driving	4.7	3.5	2.7	ns
			Open-drain driving	160	124	81	
t_{fA}	Input fall time	A port fall time	Push-pull driving	5.1	5.2	5.0	ns
			Open-drain driving	2.1	2.0	1.8	
t_{fB}	Input fall time	B port fall time	Push-pull driving	5.0	6.4	8.7	ns
			Open-drain driving	2.0	2.2	2.8	
$t_{SK(O)}$	Skew(time), output	Channel-to-channel skew		0.5	0.5	0.5	ns
Maximum data rata		Push-pull driving		20	22	24	Mbps
		Open-drain driving		2	2	2	

Switching Characteristics: V_{CCA}=3.3V ± 0.3V

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		CONDITIONS		V_{CCB}=3.3V±0.2V	V_{CCB}=5V±0.2V	UNITS
				TYP	TYP	
t_{PHL}	Propagation delay time high-to-low output	A-to-B	Push-pull driving	3.6	5.1	ns
			Open-drain driving	26.4	26.6	
t_{PLH}	Propagation delay time low-to-high output	A-to-B	Push-pull driving	2.3	2.1	ns
			Open-drain driving	155	109	
t_{PHL}	Propagation delay time high-to-low output	B-to-A	Push-pull driving	3.1	3.3	ns
			Open-drain driving	26.5	26.7	
t_{PLH}	Propagation delay time low-to-high output	B-to-A	Push-pull driving	1.9	1.8	ns
			Open-drain driving	158	87	
t_{en}	Enable time	OE-to-A or B		19	15	ns
t_{dis}	Disable time	OE-to-A or B		1250	1250	ns
t_{rA}	Input rise time	A port rise time	Push-pull driving	2.3	2.1	ns
			Open-drain driving	117	48	
t_{rB}	Input rise time	B port rise time	Push-pull driving	3.0	2.4	ns
			Open-drain driving	117	75	
t_{fA}	Input fall time	A port fall time	Push-pull driving	8.0	7.6	ns
			Open-drain driving	2.2	2.1	
t_{fB}	Input fall time	B port fall time	Push-pull driving	8.2	10.8	ns
			Open-drain driving	2.1	2.4	
$t_{SK(O)}$	Skew(time), output	Channel-to-channel skew		0.5	0.5	ns
Maximum data rata		Push-pull driving		23	24	Mbps
		Open-drain driving		2	2	

Switching Characteristics: V_{CCA}=5.0V ± 0.35V

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		CONDITIONS		V_{CCB}=5V±0.2V TYP	UNITS
t_{PHL}	Propagation delay time high-to-low output	A-to-B	Push-pull driving	5.6	ns
			Open-drain driving	26.8	
t_{PLH}	Propagation delay time low-to-high output	A-to-B	Push-pull driving	2.0	ns
			Open-drain driving	155	
t_{PHL}	Propagation delay time high-to-low output	B-to-A	Push-pull driving	5.8	ns
			Open-drain driving	27.5	
t_{PLH}	Propagation delay time low-to-high output	B-to-A	Push-pull driving	1.8	ns
			Open-drain driving	160	
t_{en}	Enable time	OE-to-A or B		17	ns
t_{dis}	Disable time	OE-to-A or B		1250	ns
t_{rA}	Input rise time	A port rise time	Push-pull driving	1.9	ns
			Open-drain driving	105	
t_{rB}	Input rise time	B port rise time	Push-pull driving	2.3	ns
			Open-drain driving	95	
t_{fA}	Input fall time	A port fall time	Push-pull driving	9.0	ns
			Open-drain driving	2.6	
t_{fB}	Input fall time	B port fall time	Push-pull driving	8.9	ns
			Open-drain driving	2.5	
$t_{SK(O)}$	Skew(time), output	Channel-to-channel skew		0.5	ns
Maximum data rata		Push-pull driving		24	Mbps
		Open-drain driving		2	

Parameter Measurement Information

Unless otherwise noted, all input pulses are supplied by generators having the following characteristics:

- PRR 10 MHz
- Z_O = 50 Ω
- dv/dt ≥ 1 V/ns

Note: All input pulses are measured one at a time, with one transition per measurement.

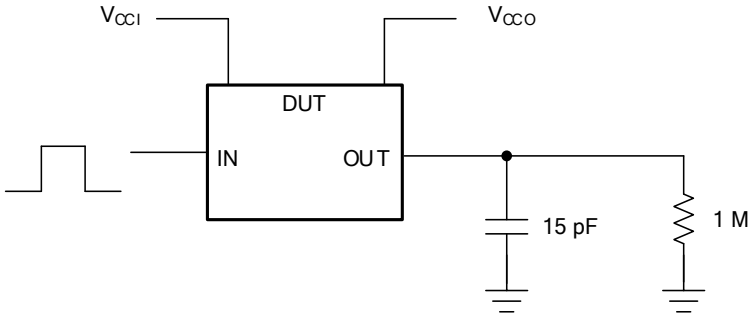


Figure 2. Data Rate, Pulse Duration, Propagation Delay, Output Rise And Fall Time Measurement Using A Push-Pull Driver

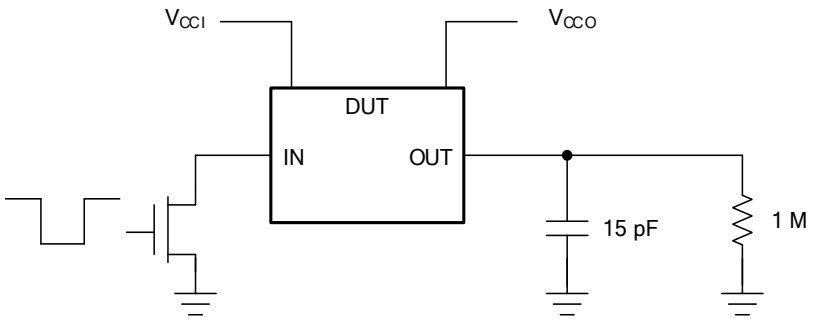


Figure 3. Data Rate, Pulse Duration, Propagation Delay, Output Rise And Fall Time Measurement Using An Open-Drain Driver

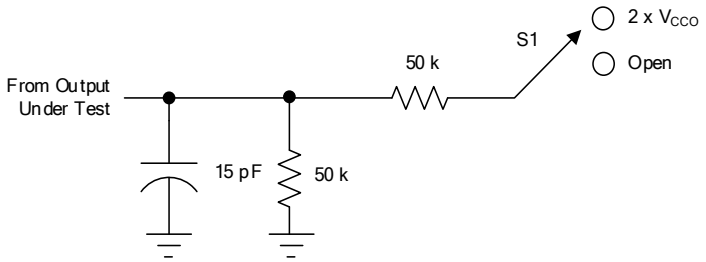
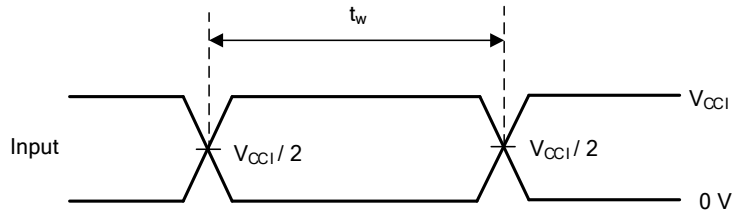


Figure 4. Load Circuit For Enable/Disable Time Measurement

Table 1. Switch Configuration For Enable/Disable Timing

TEST	S1
t_{PZL}(1), t_{PLZ}(2)	2 × V_{CCO}
t_{PHZL}(1), t_{PZH}(2)	Open

(1) t_{PZL} and t_{PZH} are the same as t_{en}.
(2) t_{PLZ} and t_{PHZ} are the same as t_{dis}.



(1) All input pulses are measured one at a time, with one transition per measurement.

Figure 5. Voltage Waveforms Pulse Duration

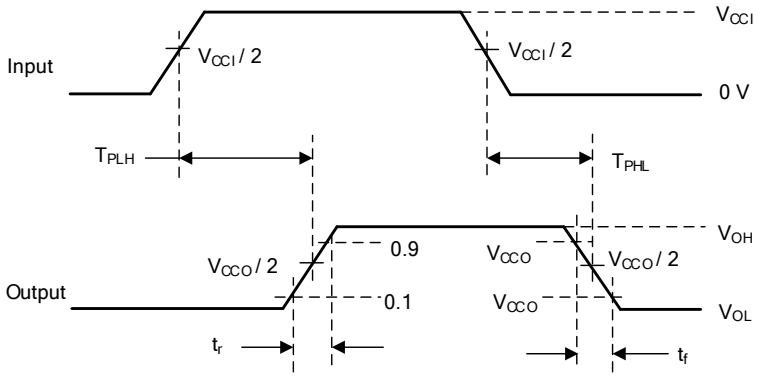


Figure 6. Voltage Waveforms Propagation Delay Times

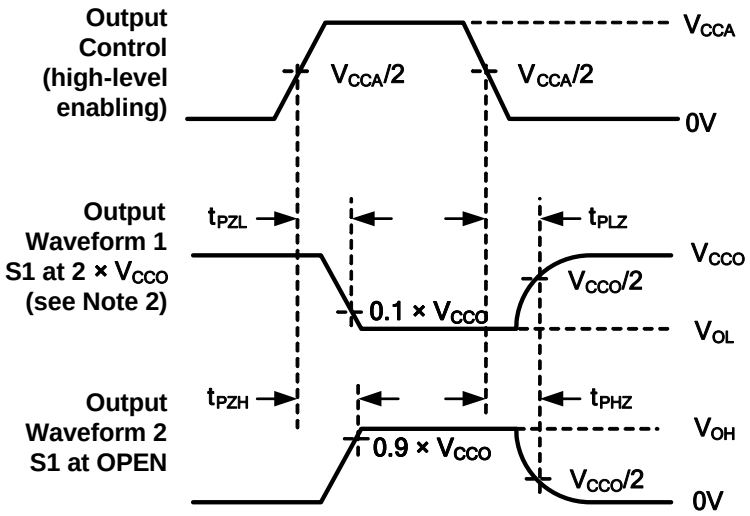


Figure 7. Voltage Waveforms Enable And Disable

Feature Description

Overview

The RS0108 device is a directionless voltage-level translator specifically designed for translating logic voltage levels. The A port is able to accept I/O voltages ranging from 1.65 V to 5.5 V, while the B port can accept I/O voltages from 2.3 V to 5.5 V. The device is a pass-gate architecture with edge-rate accelerators (one-shots) to improve the overall data rate. 10-kΩ pullup resistors, commonly used in open-drain applications, have been conveniently integrated so that an external resistor is not needed. While this device is designed for open-drain applications, the device can also translate push-pull CMOS logic outputs.

Architecture

The RS0108 architecture (see Figure 8) is an auto-direction-sensing based translator that does not require a direction-control signal to control the direction of data flow from A to B or from B to A. These two bidirectional channels independently determine the direction of data flow without a direction-control signal. Each I/O pin can be automatically reconfigured as either an input or an output, which is how this auto-direction feature is realized.

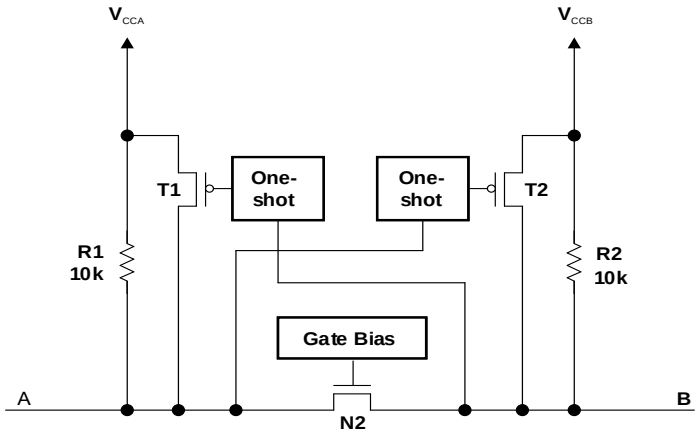


Figure 8. Architecture of a RS0108 Cell

The RS0108 employs two key circuits to enable this voltage translation:

1) An N-channel pass-gate transistor topology that ties the A-port to the B-port
2) Output one-shot (O.S.) edge-rate accelerator circuitry to detect and accelerate rising edges on the A or B Ports.

Input Driver Requirements

The continuous dc-current "sinking" capability is determined by the external system-level open-drain (or push - pull) drivers that are interfaced to the RS0108 I/O pins. Since the high bandwidth of these bidirectional I/O circuits is used to facilitate this fast change from an input to an output and an output to an input, they have a modest dc-current "sourcing" capability of hundreds of micro-Amps, as determined by the internal 10-kΩ pullup resistors.

The fall time (t_{fA}, t_{fB}) of a signal depends on the edge-rate and output impedance of the external device driving RS0108 data I/Os, as well as the capacitive loading on the data lines.

Similarly, the t_{PHL} and max data rates also depend on the output impedance of the external driver. The values for t_{fA}, t_{fB}, t_{PHL}, and maximum data rates in the data sheet assume that the output impedance of the external driver is less than 50 Ω.

Feature Description

Output Load Considerations

We recommend careful PCB layout practices with short PCB trace lengths to avoid excessive capacitive loading and to ensure that proper O.S. triggering takes place. PCB signal trace-lengths should be kept short enough such that the round-trip delay of any reflection is less than the one-shot duration. This improves signal integrity by ensuring that any reflection sees a low impedance at the driver. The O.S. circuits have been designed to stay on for approximately 30 ns. The maximum capacitance of the lumped load that can be driven also depends directly on the one-shot duration. With very heavy capacitive loads, the one-shot can time-out before the signal is driven fully to the positive rail. The O.S. duration has been set to best optimize trade-offs between dynamic ICC, load driving capability, and maximum bit-rate considerations. Both PCB trace length and connectors add to the capacitance that the RS0108 device output sees, so it is recommended that this lumped-load capacitance be considered to avoid O.S. retriggering, bus contention, output signal oscillations, or other adverse system-level affects.

Enable and Disable

The RS0108 device has an OE input that is used to disable the device by setting OE low, which places all I/Os in the Hi-Z state. The disable time (t_{dis}) indicates the delay between the time when OE goes low and when the outputs are disabled (Hi-Z). The enable time (t_{en}) indicates the amount of time the user must allow for the one-shot circuitry to become operational after OE is taken high.

Pullup or Pulldown Resistors on I/O Lines

Each A-port I/O has an internal 10-kΩ pullup resistor to V_{CCA}, and each B-port I/O has an internal 10-kΩ pullup resistor to V_{CCB}. If a smaller value of pullup resistor is required, an external resistor must be added from the I/O to V_{CCA} or V_{CCB} (in parallel with the internal 10-kΩ resistors). Adding lower value pull-up resistors will affect V_{OL} levels, however. The internal pull-ups of the RS0108 are disabled when the OE pin is low.

Application Information

The RS0108 device can be used to bridge the digital-switching compatibility gap between two voltage nodes to successfully interface logic threshold levels found in electronic systems. It should be used in a point-to-point topology for interfacing devices or systems operating at different interface voltages with one another. Its primary target application use is for interfacing with open-drain drivers on the data I/Os such as I^2C or 1-wire, where the data is bidirectional and no control signal is available. The device can also be used in applications where a push-pull driver is connected to the data I/Os, but the RS0108 might be a better option for such push-pull applications.

Typical Application

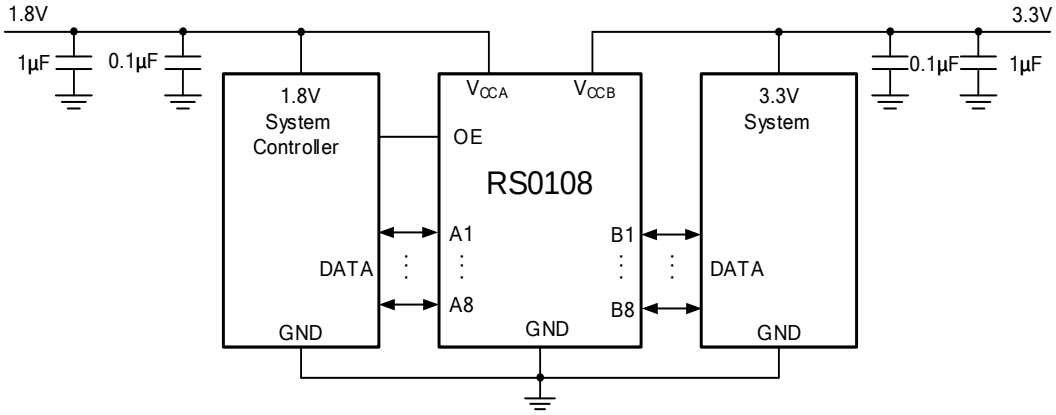
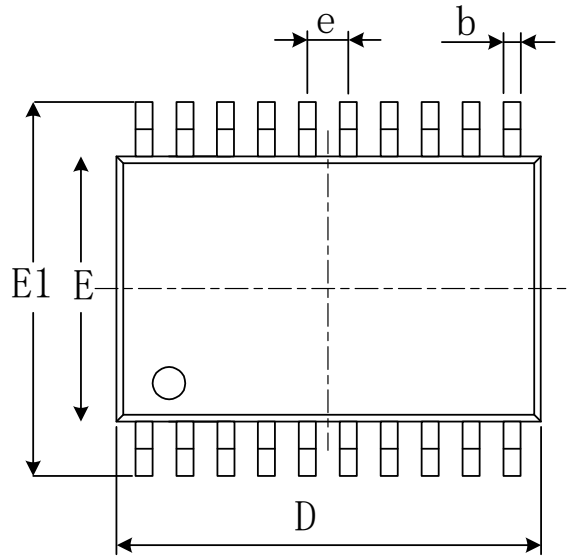
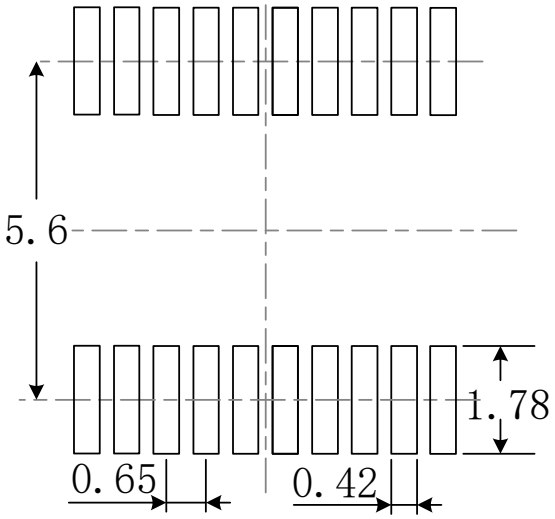


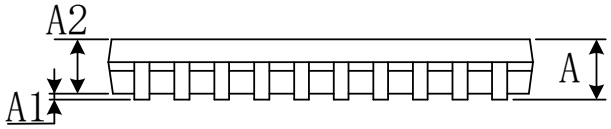
Figure 9. Typical Application Circuit

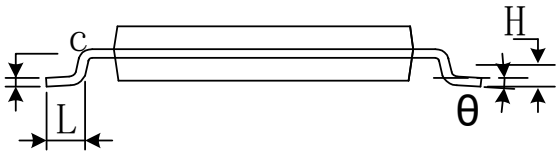
PACKAGE OUTLINE DIMENSIONS
TSSOP20





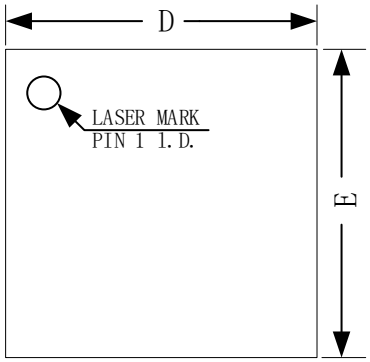
RECOMMENDED LAND PATTERN (Unit: mm)



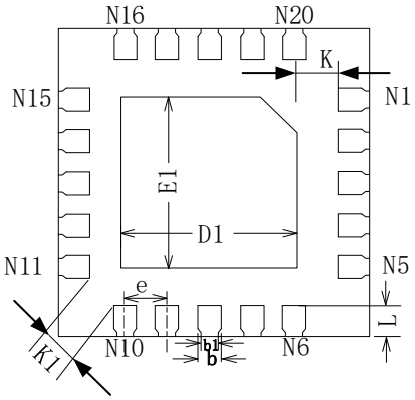


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A		1.200		0.047
A1	0.050	0.150	0.002	0.006
A2	0.800	1.050	0.031	0.041
b	0.200	0.280	0.008	0.011
c	0.130	0.170	0.005	0.007
D	6.400	6.600	0.252	0.260
E	4.300	4.500	0.169	0.177
E1	6.200	6.600	0.244	0.260
e	0.650(BSC)		0.026(BSC)	
L	0.450	0.750	0.018	0.030
H	0.250(TYP)		0.010(TYP)	
θ	0°	8°	0°	8°

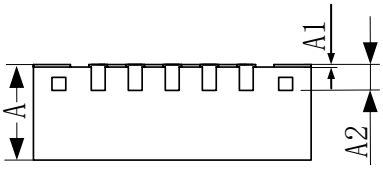
QFN3*3-20L



TOP VIEW



BOTTOM VIEW



SIDE VIEW

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.700	0.800	0.028	0.031
A1	0.000	0.050	0.000	0.002
A2	0.203REF		0.008 REF	
D	2.950	3.050	0.116	0.120
E	2.950	3.050	0.116	0.120
D1	1.550	1.650	0.061	0.065
E1	1.550	1.650	0.061	0.065
K	0.300REF		0.012REF	
K1	0.400REF		0.016REF	
b	0.150	0.250	0.006	0.010
b1	0.150REF		0.006REF	
e	0.400BSC		0.016BSC	
L	0.350	0.450	0.014	0.018

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